

#9/a

T&A-104

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

H. AOKI et al

Serial No. 09/736,282

Filed: December 15, 2000



Group Art Unit: 2133

Examiner: A. Decady

For: METHOD OF TESTING MEMORY DEVICE, METHOD OF
MANUFACTURING MEMORY DEVICE, APPARATUS FOR TESTING
MEMORY DEVICE, METHOD OF TESTING MEMORY MODULE, METHOD
OF MANUFACTURING MEMORY MODULE, APPARATUS FOR TESTING
MEMORY MODULE AND METHOD OF MANUFACTURING COMPUTER

AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RECEIVED

FEB 09 2004

Technology Center 2100

Sir:

In response to the Office Action mailed July 31, 2003,
please amend the above-identified application as follows.